

256K (32K x 8) Static RAM

Features

- **Temperature Ranges**
 - Commercial: 0°C to 70°C
 - Industrial: -40°C to 85°C
 - Automotive: -40°C to 125°C
- **High speed: 55 ns and 70 ns**
- **Voltage range: 4.5V–5.5V operation**
- **Low active power (70 ns, LL version, Com'I and Ind'I)**
 - 275 mW (max.)
- **Low standby power (70 ns, LL version, Com'I and Ind'I)**
 - 28 μW (max.)
- **Easy memory expansion with \overline{CE} and \overline{OE} features**
- **TTL-compatible inputs and outputs**
- **Automatic power-down when deselected**
- **CMOS for optimum speed/power**
- **Package available in a standard 450-mil-wide (300-mil body width) 28-lead narrow SOIC, 28-lead TSOP-1, 28-lead reverse TSOP-1, and 600-mil 28-lead PDIP packages**

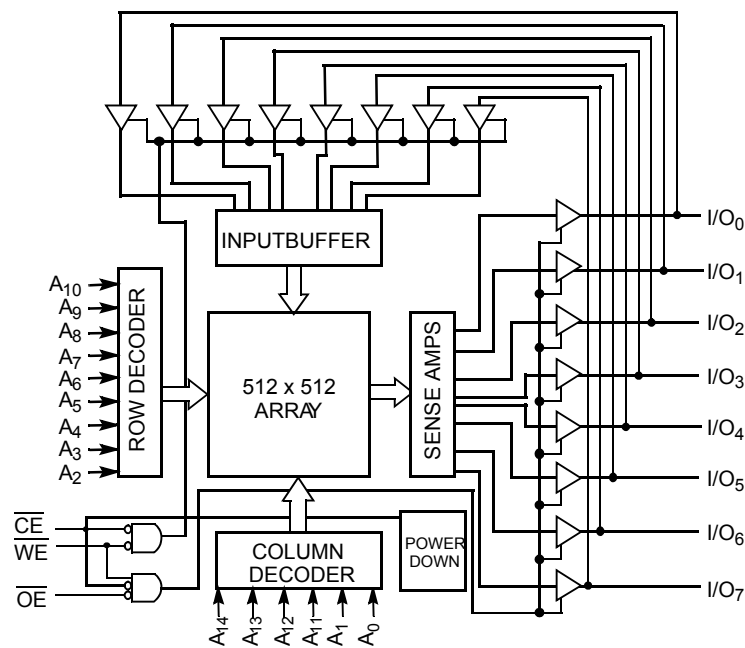
Functional Description^[1]

The CY62256 is a high-performance CMOS static RAM organized as 32K words by 8 bits. Easy memory expansion is provided by an active LOW chip enable (\overline{CE}) and active LOW output enable (\overline{OE}) and three-state drivers. This device has an automatic power-down feature, reducing the power consumption by 99.9% when deselected.

An active LOW write enable signal (\overline{WE}) controls the writing/reading operation of the memory. When \overline{CE} and \overline{WE} inputs are both LOW, data on the eight data input/output pins (I/O_0 through I/O_7) is written into the memory location addressed by the address present on the address pins (A_0 through A_{14}). Reading the device is accomplished by selecting the device and enabling the outputs, \overline{CE} and \overline{OE} active LOW, while \overline{WE} remains inactive or HIGH. Under these conditions, the contents of the location addressed by the information on address pins are present on the eight data input/output pins.

The input/output pins remain in a high-impedance state unless the chip is selected, outputs are enabled, and write enable (\overline{WE}) is HIGH.

Logic Block Diagram

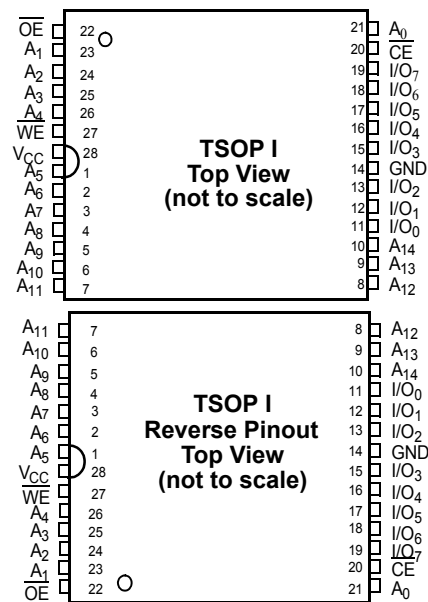
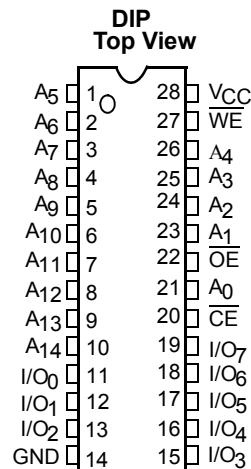
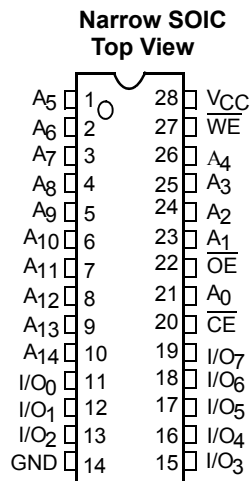


Note:

1. For best practice recommendations, please refer to the Cypress application note "System Design Guidelines" on <http://www.cypress.com>.

Product Portfolio

| Product | | V _{CC} Range (V) | | | Speed (ns) | Power Dissipation | | | |
|-----------|---------------|---------------------------|---------------------|------|------------|---------------------------------|------|--------------------------------|------|
| | | | | | | Operating, I _{CC} (mA) | | Standby, I _{SB2} (μA) | |
| | | Min. | Typ. ^[2] | Max. | | Typ. ^[2] | Max. | Typ. ^[2] | Max. |
| CY62256 | Commercial | 4.5 | 5.0 | 5.5 | 70 | 28 | 55 | 1 | 5 |
| CY62256L | Com'l / Ind'l | | | | 55/70 | 25 | 50 | 2 | 50 |
| CY62256LL | Commercial | | | | 70 | 25 | 50 | 0.1 | 5 |
| CY62256LL | Industrial | | | | 55/70 | 25 | 50 | 0.1 | 10 |
| CY62256LL | Automotive | | | | 55 | 25 | 50 | 0.1 | 15 |

Pin Configurations

Pin Definitions

| Pin Number | Type | Description |
|-----------------|---------------|--|
| 1-10, 21, 23-26 | Input | A ₀ -A ₁₄ . Address Inputs |
| 11-13, 15-19, | Input/Output | I/O ₀ -I/O ₇ . Data lines. Used as input or output lines depending on operation |
| 27 | Input/Control | WE. When selected LOW, a WRITE is conducted. When selected HIGH, a READ is conducted |
| 20 | Input/Control | CE. When LOW, selects the chip. When HIGH, deselects the chip |
| 22 | Input/Control | OE. Output Enable. Controls the direction of the I/O pins. When LOW, the I/O pins behave as outputs. When deasserted HIGH, I/O pins are three-stated, and act as input data pins |
| 14 | Ground | GND. Ground for the device |
| 28 | Power Supply | V _{CC} . Power supply for the device |

Notes:

- Typical specifications are the mean values measured over a large sample size across normal production process variations and are taken at nominal conditions (T_A = 25°C, V_{CC}). Parameters are guaranteed by design and characterization, and not 100% tested.

Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature -65°C to +150°C
 Ambient Temperature with Power Applied..... -55°C to +125°C
 Supply Voltage to Ground Potential (Pin 28 to Pin 14) -0.5V to +7.0V
 DC Voltage Applied to Outputs in High-Z State^[3] -0.5V to $V_{CC} + 0.5V$
 DC Input Voltage^[3] -0.5V to $V_{CC} + 0.5V$

Output Current into Outputs (LOW)..... 20 mA
 Static Discharge Voltage..... > 2001V (per MIL-STD-883, Method 3015)
 Latch-up Current..... > 200 mA

Operating Range

| Range | Ambient Temperature (T_A) ^[4] | V_{CC} |
|------------|--|----------|
| Commercial | 0°C to +70°C | 5V ± 10% |
| Industrial | -40°C to +85°C | 5V ± 10% |
| Automotive | -40°C to +125°C | 5V ± 10% |

Electrical Characteristics Over the Operating Range

| Parameter | Description | Test Conditions | CY62256-55 | | | CY62256-70 | | | Unit |
|-----------|---|--|------------|---------------------|-----------------|------------|---------------------|-----------------|------|
| | | | Min. | Typ. ^[2] | Max. | Min. | Typ. ^[2] | Max. | |
| V_{OH} | Output HIGH Voltage | $V_{CC} = \text{Min.}, I_{OH} = -1.0 \text{ mA}$ | 2.4 | | | 2.4 | | | V |
| V_{OL} | Output LOW Voltage | $V_{CC} = \text{Min.}, I_{OL} = 2.1 \text{ mA}$ | | | 0.4 | | | 0.4 | V |
| V_{IH} | Input HIGH Voltage | | 2.2 | | $V_{CC} + 0.5V$ | 2.2 | | $V_{CC} + 0.5V$ | V |
| V_{IL} | Input LOW Voltage | | -0.5 | | 0.8 | -0.5 | | 0.8 | V |
| I_{IX} | Input Leakage Current | $GND \leq V_I \leq V_{CC}$ | -0.5 | | +0.5 | -0.5 | | +0.5 | μA |
| I_{OZ} | Output Leakage Current | $GND \leq V_O \leq V_{CC}$, Output Disabled | -0.5 | | +0.5 | -0.5 | | +0.5 | μA |
| I_{CC} | V_{CC} Operating Supply Current | $V_{CC} = \text{Max.}, I_{OUT} = 0 \text{ mA}, f = f_{MAX} = 1/t_{RC}$ | | 28 | 55 | 28 | 55 | mA | |
| | | | L | 25 | 50 | 25 | 50 | mA | |
| | | | LL | 25 | 50 | 25 | 50 | mA | |
| I_{SB1} | Automatic CE Power-down Current—TTL Inputs | Max. V_{CC} , $\overline{CE} \geq V_{IH}$, $V_{IN} \geq V_{IH}$ or $V_{IN} \leq V_{IL}$, $f = f_{MAX}$ | | 0.5 | 2 | 0.5 | 2 | mA | |
| | | | L | 0.4 | 0.6 | 0.4 | 0.6 | mA | |
| | | | LL | 0.3 | 0.5 | 0.3 | 0.5 | mA | |
| I_{SB2} | Automatic CE Power-down Current—CMOS Inputs | Max. V_{CC} , $\overline{CE} \geq V_{CC} - 0.3V$, $V_{IN} \geq V_{CC} - 0.3V$, or $V_{IN} \leq 0.3V$, $f = 0$ | | 1 | 5 | 1 | 5 | mA | |
| | | | L | 2 | 50 | 2 | 50 | μA | |
| | | | LL | 0.1 | 5 | 0.1 | 5 | μA | |
| | | | LL - Ind'l | 0.1 | 10 | 0.1 | 10 | μA | |
| | | | LL - Auto | 0.1 | 15 | | | μA | |

Capacitance^[5]

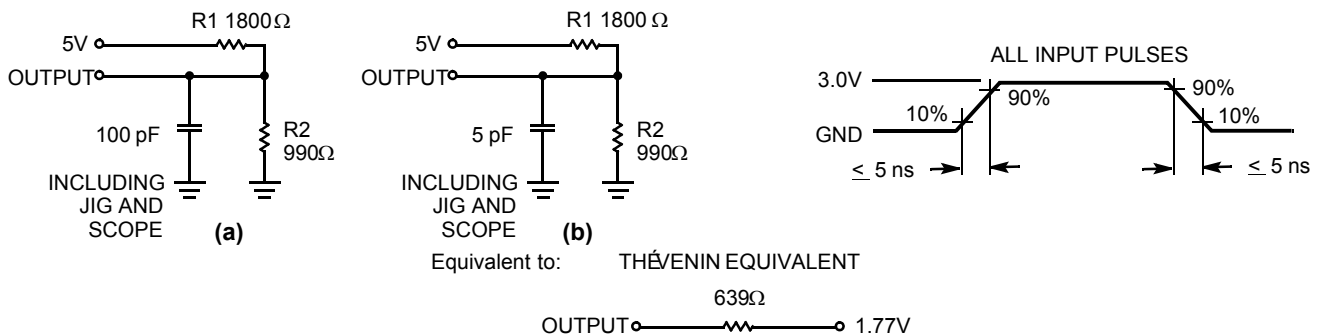
| Parameter | Description | Test Conditions | Max. | Unit |
|-----------|--------------------|--|------|------|
| C_{IN} | Input Capacitance | $T_A = 25^\circ\text{C}, f = 1 \text{ MHz}, V_{CC} = 5.0V$ | 6 | pF |
| C_{OUT} | Output Capacitance | | 8 | pF |

Notes:

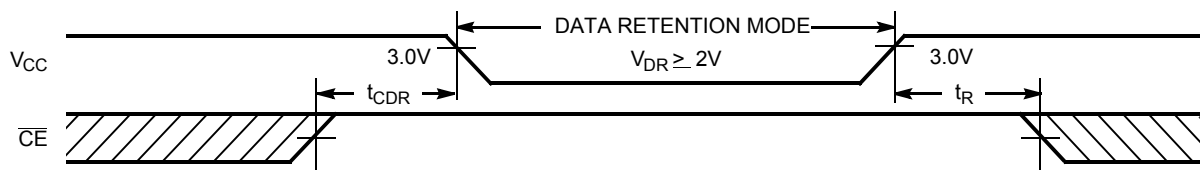
- V_{IL} (min.) = -2.0V for pulse durations of less than 20 ns.
- T_A is the "Instant-On" case temperature.
- Tested initially and after any design or process changes that may affect these parameters.

Thermal Resistance

| Description | Test Conditions | Symbol | DIP | SOIC | TSOP | RTSOP | Unit |
|---|---|---------------|-------|-------|-------|-------|------|
| Thermal Resistance (Junction to Ambient) ^[5] | Still Air, soldered on a 4.25 x 1.125 inch, 4-layer printed circuit board | Θ_{JA} | 75.61 | 76.56 | 93.89 | 93.89 | °C/W |
| Thermal Resistance (Junction to Case) ^[5] | | Θ_{JC} | 43.12 | 36.07 | 24.64 | 24.64 | °C/W |

AC Test Loads and Waveforms

Data Retention Characteristics

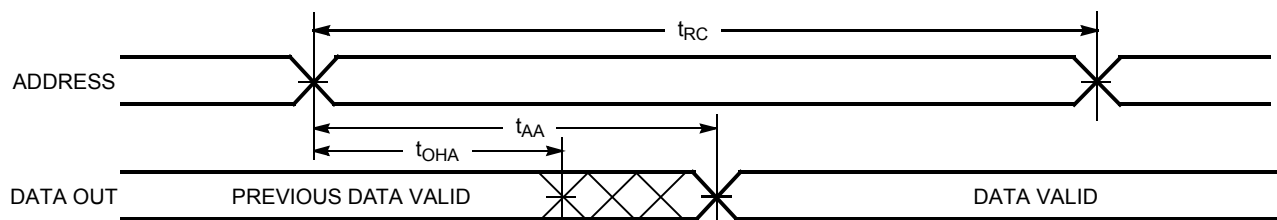
| Parameter | Description | Conditions ^[6] | Min. | Typ. ^[2] | Max. | Unit |
|-----------------|--------------------------------------|---------------------------|--|---------------------|------|---------|
| V_{DR} | V_{CC} for Data Retention | | 2.0 | | | V |
| I_{CCDR} | Data Retention Current | L | $V_{CC} = 3.0V, CE \geq V_{CC} - 0.3V,$ $V_{IN} \geq V_{CC} - 0.3V, \text{ or } V_{IN} \leq 0.3V$ | 2 | 50 | μA |
| | | LL | | 0.1 | 5 | μA |
| | | LL - Ind'l | | 0.1 | 10 | μA |
| | | LL - Auto | | 0.1 | 10 | μA |
| $t_{CDR}^{[5]}$ | Chip Deselect to Data Retention Time | | 0 | | | ns |
| $t_R^{[5]}$ | Operation Recovery Time | | t_{RC} | | | ns |

Data Retention Waveform

Notes:

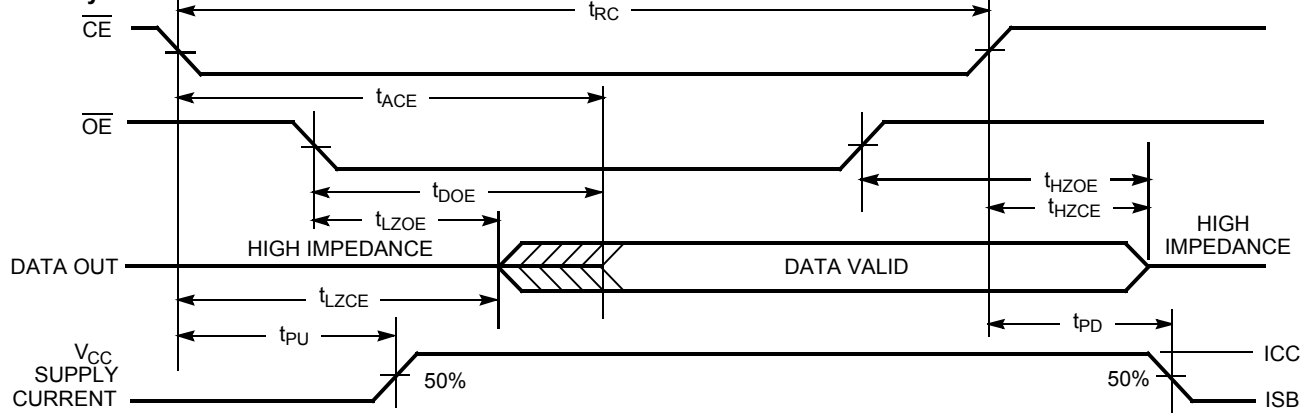
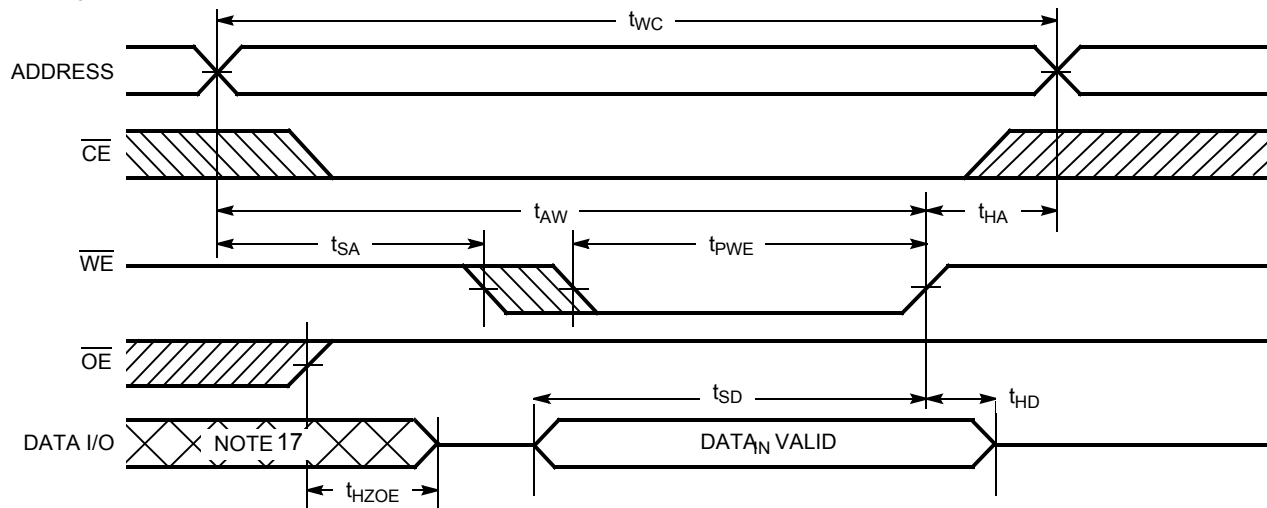
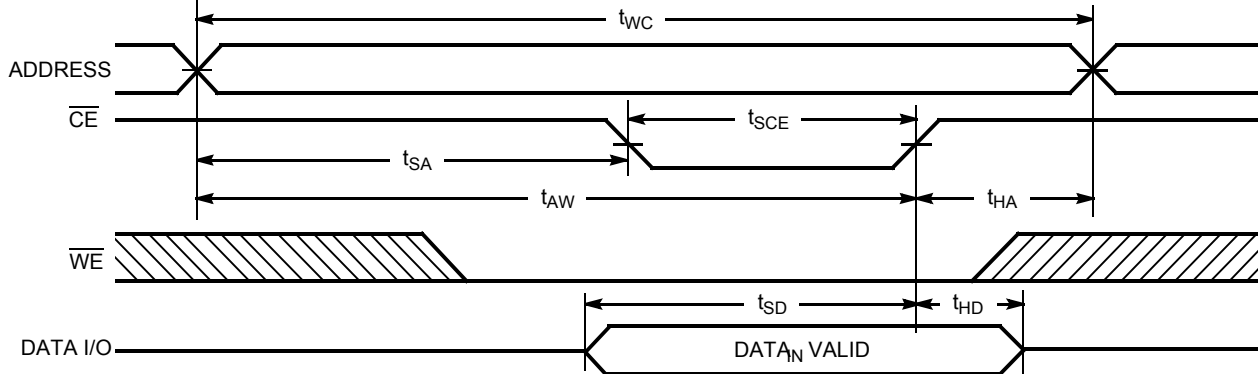
6. No input may exceed $V_{CC} + 0.5V$.

Switching Characteristics Over the Operating Range^[7]

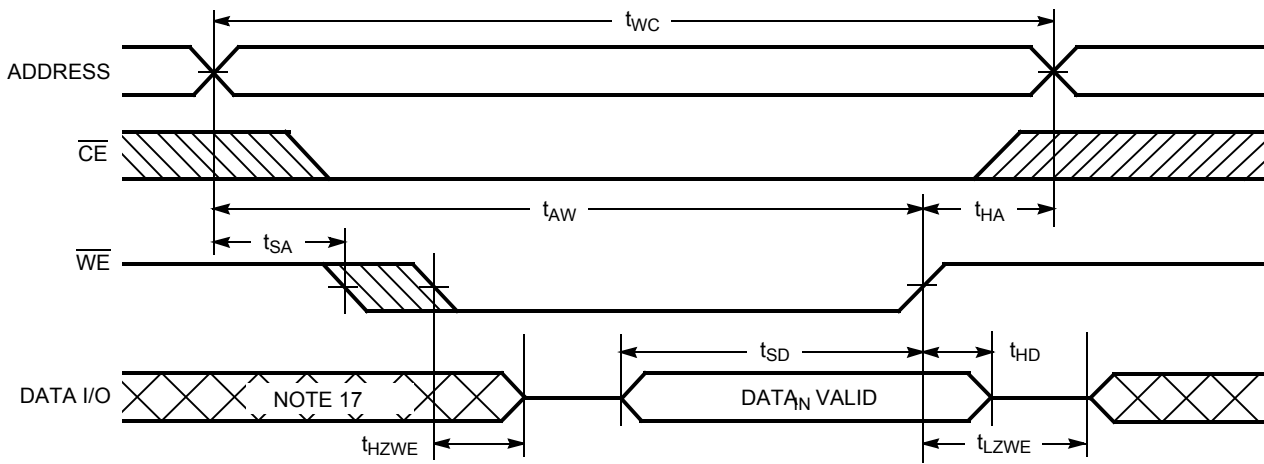
| Parameter | Description | CY62256-55 | | CY62256-70 | | Unit |
|---------------------------------------|-------------------------------------|------------|------|------------|------|------|
| | | Min. | Max. | Min. | Max. | |
| Read Cycle | | | | | | |
| t_{RC} | Read Cycle Time | 55 | | 70 | | ns |
| t_{AA} | Address to Data Valid | | 55 | | 70 | ns |
| t_{OHA} | Data Hold from Address Change | 5 | | 5 | | ns |
| t_{ACE} | CE LOW to Data Valid | | 55 | | 70 | ns |
| t_{DOE} | OE LOW to Data Valid | | 25 | | 35 | ns |
| t_{LZOE} | OE LOW to Low-Z ^[8] | 5 | | 5 | | ns |
| t_{HZOE} | OE HIGH to High-Z ^[8, 9] | | 20 | | 25 | ns |
| t_{LZCE} | CE LOW to Low-Z ^[8] | 5 | | 5 | | ns |
| t_{HZCE} | CE HIGH to High-Z ^[8, 9] | | 20 | | 25 | ns |
| t_{PU} | CE LOW to Power-up | 0 | | 0 | | ns |
| t_{PD} | CE HIGH to Power-down | | 55 | | 70 | ns |
| Write Cycle^[10, 11] | | | | | | |
| t_{WC} | Write Cycle Time | 55 | | 70 | | ns |
| t_{SCE} | CE LOW to Write End | 45 | | 60 | | ns |
| t_{AW} | Address Set-up to Write End | 45 | | 60 | | ns |
| t_{HA} | Address Hold from Write End | 0 | | 0 | | ns |
| t_{SA} | Address Set-up to Write Start | 0 | | 0 | | ns |
| t_{PWE} | WE Pulse Width | 40 | | 50 | | ns |
| t_{SD} | Data Set-up to Write End | 25 | | 30 | | ns |
| t_{HD} | Data Hold from Write End | 0 | | 0 | | ns |
| t_{HZWE} | WE LOW to High-Z ^[8, 9] | | 20 | | 25 | ns |
| t_{LZWE} | WE HIGH to Low-Z ^[8] | 5 | | 5 | | ns |

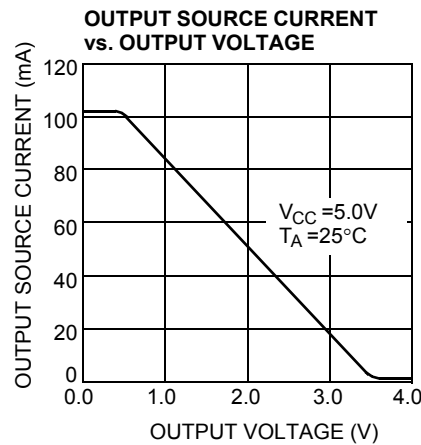
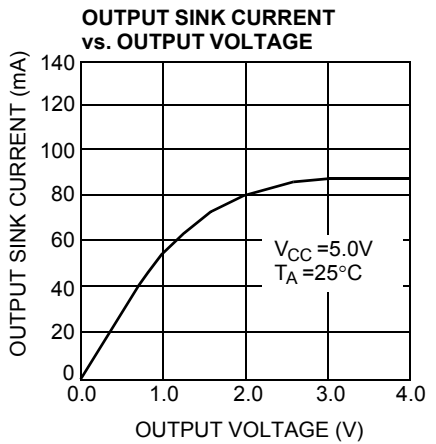
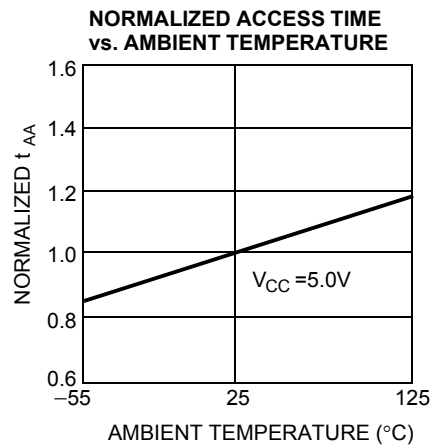
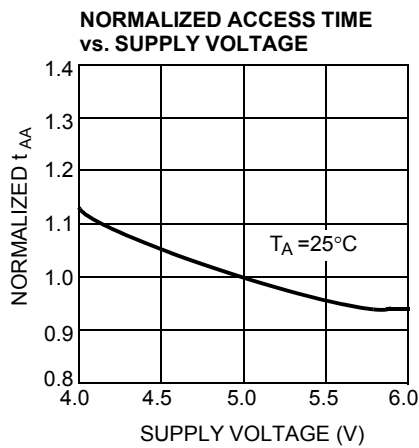
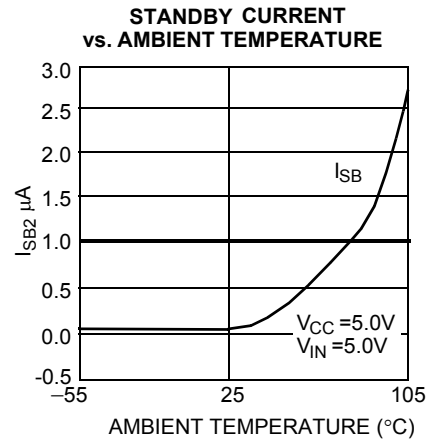
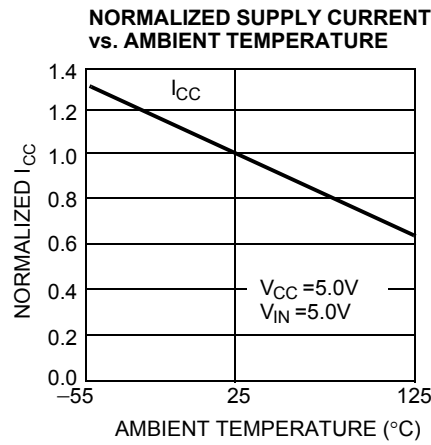
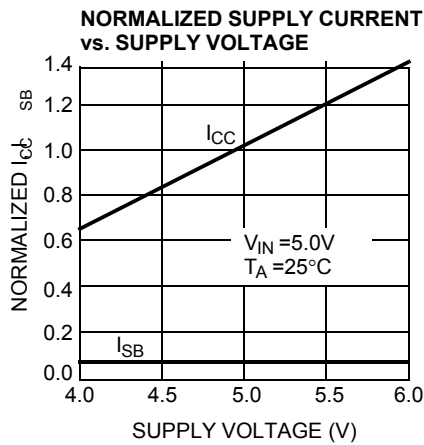
Switching Waveforms
Read Cycle No. 1^[12, 13]

Notes:

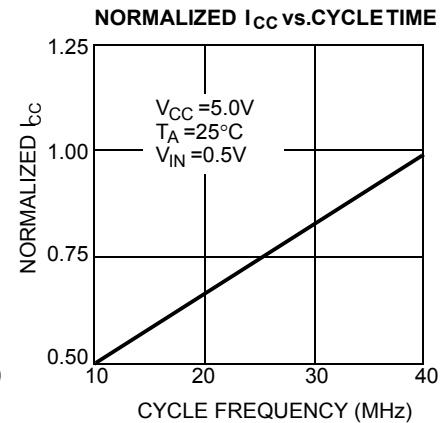
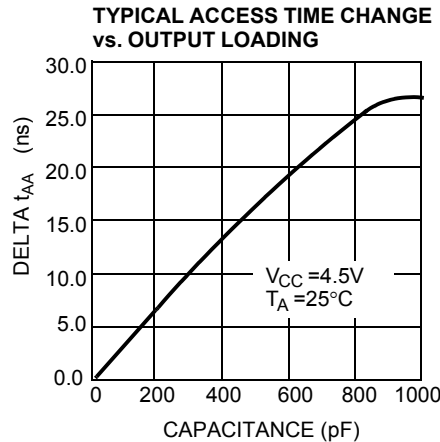
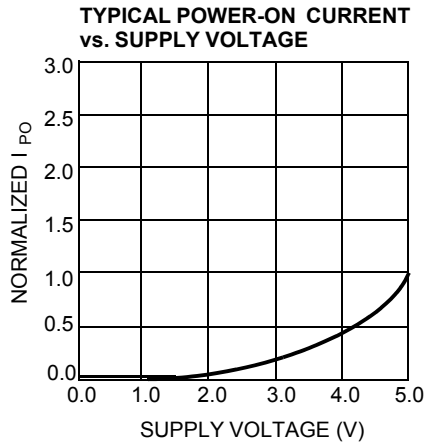
7. Test conditions assume signal transition time of 5 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3.0V, and output loading of the specified I_{OL}/I_{OH} and 100-pF load capacitance.
8. At any given temperature and voltage condition, t_{HZCE} is less than t_{LZCE} , t_{HZOE} is less than t_{LZOE} , and t_{HZWE} is less than t_{LZWE} for any given device.
9. t_{HZOE} , t_{HZCE} , and t_{HZWE} are specified with $C_L = 5$ pF as in (b) of AC Test Loads. Transition is measured ± 500 mV from steady-state voltage.
10. The internal Write time of the memory is defined by the overlap of CE LOW and WE LOW. Both signals must be LOW to initiate a Write and either signal can terminate a Write by going HIGH. The data input set-up and hold timing should be referenced to the rising edge of the signal that terminates the Write.
11. The minimum Write cycle time for Write cycle #3 (WE controlled, OE LOW) is the sum of t_{HZWE} and t_{SD} .
12. Device is continuously selected. \overline{OE} , $\overline{CE} = V_{IL}$.
13. WE is HIGH for Read cycle.

Switching Waveforms (continued)
Read Cycle No. 2 [13, 14]

Write Cycle No. 1 (WE Controlled) [10, 15, 16]

Write Cycle No. 2 (\overline{CE} Controlled) [10, 15, 16]

Notes:

14. Address valid prior to or coincident with \overline{CE} transition LOW.
15. Data I/O is high impedance if $OE = V_{IH}$.
16. If \overline{CE} goes HIGH simultaneously with \overline{WE} HIGH, the output remains in a high-impedance state.
17. During this period, the I/Os are in output state and input signals should not be applied.

Switching Waveforms (continued)
Write Cycle No. 3 (\overline{WE} Controlled, \overline{OE} LOW) [11, 16]


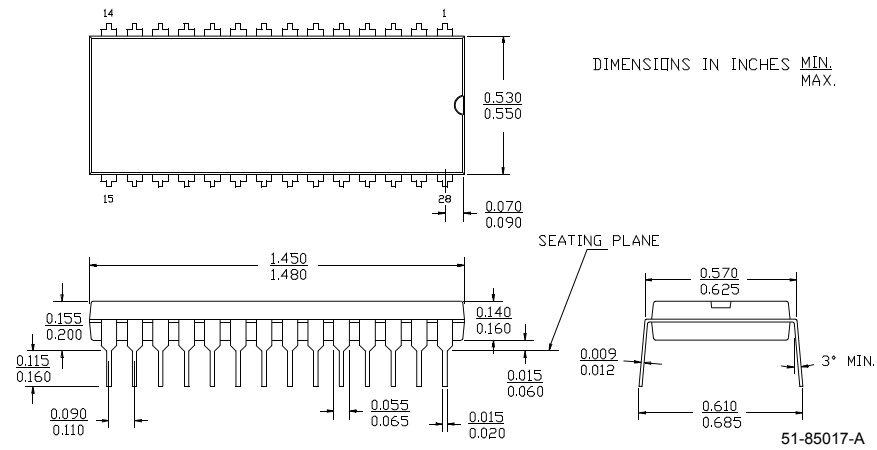
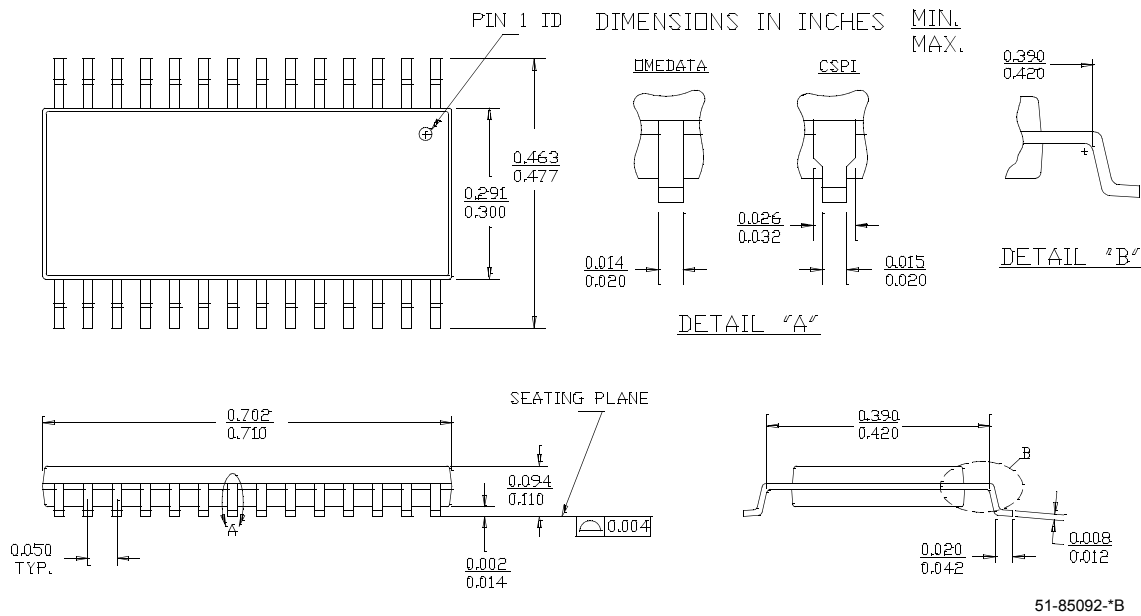
Typical DC and AC Characteristics


Typical DC and AC Characteristics (continued)

Truth Table

| CE | WE | OE | Inputs/Outputs | Mode | Power |
|----|----|----|----------------|---------------------|----------------------|
| H | X | X | High-Z | Deselect/Power-down | Standby (I_{SB}) |
| L | H | L | Data Out | Read | Active (I_{CC}) |
| L | L | X | Data In | Write | Active (I_{CC}) |
| L | H | H | High-Z | Output Disabled | Active (I_{CC}) |

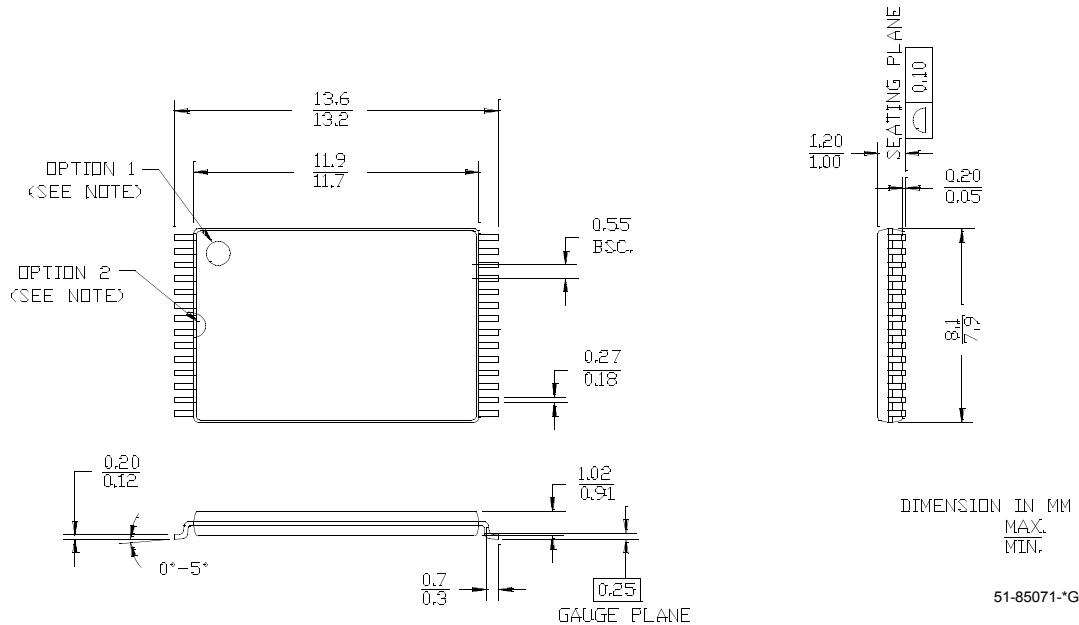
Ordering Information

| Speed (ns) | Ordering Code | Package Name | Package Type | Operating Range |
|-----------------|-----------------|--|--|-----------------|
| 55 | CY62256LL-55SNI | SN28 | 28-lead (300-Mil Narrow Body) Narrow SOIC | Industrial |
| | CY62256LL-55ZI | Z28 | 28-lead Thin Small Outline Package | |
| | CY62256LL-55SNE | SN28 | 28-lead (300-Mil Narrow Body) Narrow SOIC | Automotive |
| | CY62256LL-55ZE | Z28 | 28-lead Thin Small Outline Package | |
| | CY62256LL-55ZRE | ZR28 | 28-lead Reverse Thin Small Outline Package | |
| 70 | CY62256-70SNC | SN28 | 28-lead (300-Mil Narrow Body) Narrow SOIC | Commercial |
| | CY62256L-70SNC | | | |
| | CY62256LL-70SNC | | | |
| | CY62256L-70SNI | | | Industrial |
| | CY62256LL-70SNI | | | |
| | CY62256LL-70ZC | Z28 | 28-lead Thin Small Outline Package | Commercial |
| | CY62256LL-70ZI | Z28 | | Industrial |
| | CY62256-70PC | P15 | 28-lead (600-Mil) Molded DIP | Commercial |
| | CY62256L-70PC | | | |
| | CY62256LL-70PC | | | |
| CY62256LL-70ZRI | ZR28 | 28-lead Reverse Thin Small Outline Package | Industrial | |

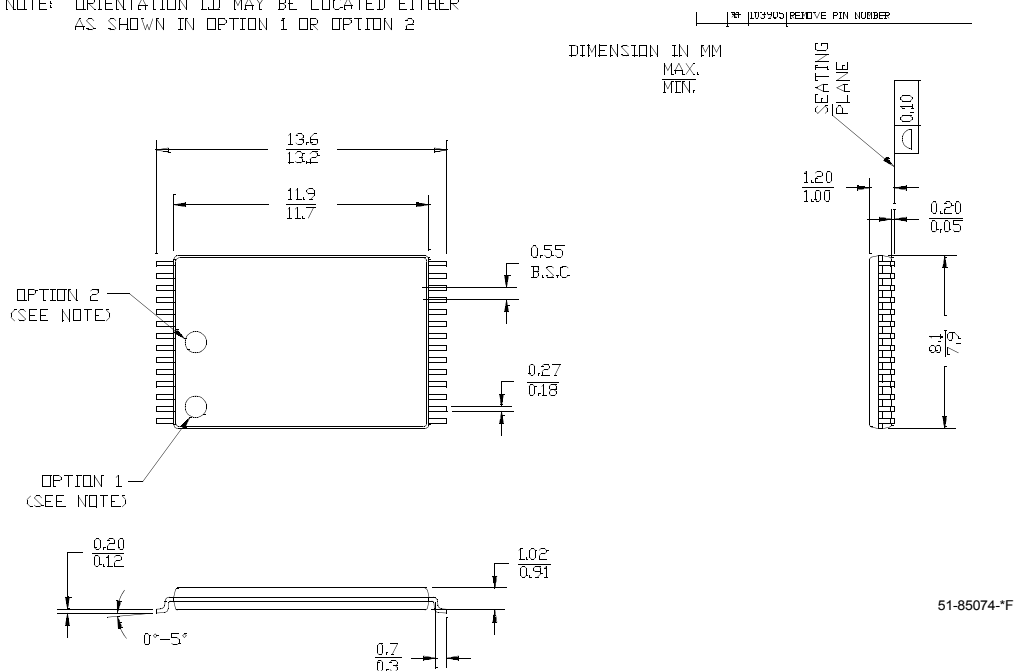
Package Diagrams
28-lead (600-mil) Molded DIP P15

28-lead (300-mil) SNC (Narrow Body) SN28


Package Diagrams (continued)
28-lead Thin Small Outline Package Type 1 (8 x 13.4 mm) Z28

NOTE: ORIENTATION I.D. MAY BE LOCATED EITHER AS SHOWN IN OPTION 1 OR OPTION 2


28-lead Reverse Type 1 Thin Small Outline Package (8 x 13.4 mm) ZR28

NOTE: ORIENTATION I.D. MAY BE LOCATED EITHER AS SHOWN IN OPTION 1 OR OPTION 2



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Document Title: CY62256 256K (32K x 8) Static RAM
Document Number: 38-05248

| REV. | ECN NO. | Issue Date | Orig. of Change | Description of Change |
|------|---------|------------|-----------------|---|
| ** | 113454 | 03/06/02 | MGN | Change from Spec number: 38-00455 to 38-05248 Remove obsolete parts from ordering info, standardize format |
| *A | 115227 | 05/23/02 | GBI | Changed SN Package Diagram |
| *B | 116506 | 09/04/02 | GBI | Added footnote 1. Corrected package description in Ordering Information table |
| *C | 238448 | See ECN | AJU | Added Automotive product information |